

**Minutes of TC-10 Meeting of
June 14, 2006 in Colorado Springs, Colorado**

Attendance:

Tom Linnenbrink	Hittite Microwave
Jerry Blair	Bechtel Nevada
Sol Max	LTX Corporation
Bill Boyer	Sandia (retired)
Bob Graham	Sandia
Fang Xu	Teradyne
Nick Paulter (by phone)	NIST

Minutes prepared by Jerry Blair.

- Review of minutes from previous meeting. The minutes were accepted after correcting the spelling of IMTC07.
- SCOPT Report
 - The IEEE is still working on dual logo process. We do not know what they are doing. We may have to form a subcommittee of the IEC. The dual logo was originally refused because of lack of international cooperation. Tom will email Braudaway and Jodie at IEEE to see what is happening.
 - Probe activity. The PAR was just approved. Tek and LeCroy are interested, Agilent only because other companies are. A plan will be constructed by email and teleconference.
- Correspondance and Administration.
 - We received a letter from Richard Liggiero. He supplied tutorial material from ADI. He is moving to LTX and another person will take over from ADI.
 - We received a letter from Michael Stora regarding the Synthetic Instrument standard development. We are not likely to get very involved.
 - IWADC2006. We have had an informal request to participate IWADC 2006 in Brazil in September. We do not have anyone attending. More information is at <http://www.iwadc2006.org.br/>
 - Web Page. We need to correct Bill Boyer's email address and get electronic membership forms working.
- Waveform Committee Report
 - Meetings were held in Sorrento and Colorado Springs.
 - We plan to ballot in the fall of 2006.

- ADC Committee Report
 - The standard is being reviewed. There will be a meeting this afternoon.
- DAC Committee Report
 - Additions to the draft will be reviewed tomorrow.
- ADC Forum.
 - Hittite provided the keynote speaker for the ADC Forum at IMTC06.
 - Fang Xu got the best paper award.
 - We will begin scheduling for another one at IMTC in Victoria in 2008.
- Future Projects
 - Tutorial 7 Table. A table giving parameters vs. test setup will be added in a future issue of the I&M Magazine.
 - Other magazines. Bob Graham handed out copies NCSL international Measure additional copies are available by emailing him. We could do short articles for Tech Tips on how to make particular measurements.
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- Next Meetings
 - The next meeting will be in Albuquerque, New Mexico the week of October 31.
 - The winter meeting will be in February, 2007. Possible locations are at NIST in Gaithersburg, Maryland or in the Boston, Massachusetts area at LTX or Hittite.